


<b>Search Notes</b> 	<b>Application/Control No.</b> 10594886	<b>Applicant(s)/Patent Under Reexamination</b> SOYA, HIDEKI
	<b>Examiner</b> Williams, Don	<b>Art Unit</b> 2878

SEARCHED			
Class	Subclass	Date	Examiner
250	208.1, 214R	12/2/2008	DW
348	294, 311, 312, 220	12/2/2008	DW
257	59, 219, 221	12/2/2008	DW
	Search Updated	6/23/2009	DW

SEARCH NOTES		
Search Notes	Date	Examiner
East:BRS, US_PGPUB, USPAT, USOCR, EPO, JPO, DERWENT, IBM_TDB	12/2/2008	DW
Application PCT/JP05/05911 has been considered.	12/2/2008	DW
Consulted with Examiner Pyo of Class 250.	12/2/2008	DW
Consulted with Examiner Pyo of Class 250.	6/23/2009	DW

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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